

Fig. 2. Two-tone linearity measurement of the transceiver as a waveguide modulator showing fundamental (squares) and third-order intermodulation product (circles) signals. (a) For the broad-band measurement, with 43 mW (TM polarized) light incident onto the device, the extrapolated spurious-free dynamic range at 4 GHz is 106 dB-Hz^{2/3} with 2.6 mA of detector photocurrent. (b) For the narrow-band measurement, with 37 mW (TM polarized) light incident onto the device, the extrapolated spurious-free dynamic range at 4 GHz is 124 dB-Hz^{4/5} with 0.66 mA of detector photocurrent.

modulation and detection characteristics of the semiconductor device are critical to this approach and our results show that little link performance is sacrificed (5 dB added RF link loss due to reduced detector responsivity) in comparison to using a separate optical modulator and a dedicated 0.8 A/W responsivity detector at the antenna site.

II. EXPERIMENTAL

The transceiver structure described herein is the same as reported previously [8]. Briefly, it consists of an undoped InGaAsP ($\lambda = 1.24$ μ m) absorbing layer (0.35 μ m thick), sandwiched between p- and n- InP layers. An etched mesa of 3 to 5 μ m provides lateral light confinement. The waveguides are cleaved to a length of approximately 120 μ m. Antireflection coatings are e-beam deposited at the facets to improve the coupling into and out of the waveguide. The measured 3-dB electrical bandwidth for the lumped element device without any matching circuit or termination resistor, is 11 GHz for both modulator and detector operation.

Two experiments are performed to characterize the usefulness of the device in each mode of operation. First, the device is tested as a waveguide modulator, in a fiber link consisting of a high-power 1.32 μ m Nd:YAG laser source, an optical polarization controller, the EA modulator, and a surface-illuminated InGaAs p-i-n photodiode (0.77 A/W

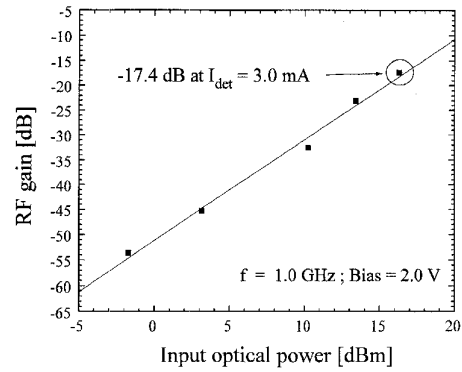


Fig. 3. RF gain at 1 GHz versus input optical power of the transceiver as a waveguide modulator.

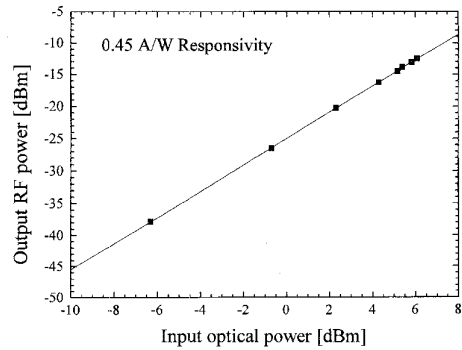


Fig. 4. Detected RF signal power at 4 GHz plotted versus input optical power of the transceiver as a waveguide detector.

DC responsivity; 6.5 GHz 3-dB electrical bandwidth). The maximum power incident to the modulator is 43 mW. Two RF tones are supplied to the electrical input through a power combiner, ferroelectric isolators, and a bias- T . Second, the device is tested as a detector, with two temperature-tuned, 1.32 μ m Nd:YAG lasers providing the RF signal in a heterodyne configuration. The output of one of the lasers goes into a polarization controller, the output of which is fed into a 3-dB coupler along with the other laser output. One output of the coupler (output power of 4 mW) feeds into a variable attenuator and the waveguide detector. Both modulator and detector responsivity, saturation, and linearity are examined. In the case of the device operating as a waveguide detector, comparison is made to a high speed, surface-illuminated InGaAs photodiode.

III. WAVEGUIDE MODULATOR PERFORMANCE

The primary concerns for the transceiver as a modulator are large linear dynamic range and high-RF efficiency. These are simultaneously maximized in broad-band or multiple-octave applications by biasing the waveguide device at the maximum slope point on the dc transfer curve, where the second derivative is zero. This null point occurs at 2.0 V for the present device. The broad-band linearity is investigated for the modulator biased at 2.0 V, and results of the two-tone measurement at 4 GHz are shown in Fig. 2(a). For this measurement, the shot-noise-limited detector dc photocurrent is 2.6 mA. The dominant distortion is the third-order inter-

modulation term. The third-order intercept point (IP3) is -3.6 dBm (output referenced), thus the SFDR extrapolated to the calculated noise floor is 106 dB for a 1-Hz noise bandwidth.

It should be noted that biasing the modulator at the point on the transfer curve where the third derivative is zero, gives a reduction in the third-order intermodulation term [8]. This is desired in high center-frequency, narrow-bandwidth, antenna remoting applications, because the second-order distortions are out of the passband. For the present device, the null bias is 2.93 V with 37 mW incident optical power. Biasing at this null point results in a 0.66 mA dc photocurrent at the detector and a measured SFDR of 124 dB in a 1-Hz noise bandwidth, as shown in Fig. 2(b). The dominant distortion is the third-order intermodulation term, which has a fifth-order power dependence. To maintain the high suboctave and multi-octave SFDR modulator performance over temperature, active modulator bias control is required. Simulation has shown that the modulator bias voltage must be maintained to better than ± 3 mV to incur less than 5-dB SFDR degradation [8].

Fig. 3 shows the measured RF gain at 1 GHz with 6 percent modulation depth versus the input optical power for the modulator biased at 2.0 V, giving the largest RF gain possible for this device. The RF gain of the link shows no saturation up to 43-mW optical power, the largest power available for this measurement. The large power handling capability of this EA modulator enables a substantial RF signal gain, despite the small depths of modulation for spurious signal-free operation. An RF link gain of -17.4 dB with 3.0 mA of dc photocurrent at the detector has been measured representing the largest link gain reported for an EA modulator.

IV. WAVEGUIDE DETECTOR PERFORMANCE

In the detector mode, the transceiver is biased at 7.0 V to assure large absorption. Fig. 4 shows the detected RF signal power at 4 GHz plotted versus input optical power using the two beaters. The measurement shows no RF saturation for power levels up to 4 mW, and the measured RF power agrees with values calculated from the measured dc responsivity, \mathcal{R} , of 0.45 A/W. Additionally, the dc responsivity is maintained to very large incident optical powers. The maximum photocurrent measured is 20 mA with the maximum incident power from the high-power laser.

The RF output power of a square-law detector is given by

$$1/4 \cdot m^2 \cdot (P_{\text{OPT}})^2 \cdot \mathcal{R}^2 \cdot R_d \quad (1)$$

where m is the modulation depth, R_d is the load impedance (50Ω) and P_{OPT} is the optical power. In the heterodyned configuration with equal input powers from the two lasers, the modulation depth is one. As can be seen from (1), using a commercially available 11 GHz InGaAs detector [10] with a responsivity of 0.8 A/W gives a larger detected RF power. Therefore, the smaller responsivity of the waveguide detector results in a theoretical RF link gain penalty of 5.0 dB compared to the surface-illuminated InGaAs detector. It is noted that although the RF efficiency of the waveguide device is relatively lower, larger optical powers and frequency

bandwidths have been achieved with waveguide photodiodes [11], [12].

The nonlinearity of the waveguide detector is investigated at the second-harmonic frequency of the 4 GHz signal. The second-order intercept point (IP2) is extrapolated to $+34.5$ dBm (output referenced) from the measured second harmonics. The IP3 limits the narrow-band dynamic range of the link the same way as IP2 limits the broad-band dynamic range. Determination of this nonlinear intercept-point is presently limited by the low optical power available from the two beaters in our measurement. In the worse case of the third-harmonic power at the measurement noise floor, the extrapolated IP3 would be $+23$ dBm.

V. CONCLUSION

An InGaAsP-InP waveguide transceiver device is demonstrated as a dual-function modulator and detector. This device has the largest reported link gain of -17.4 dB when used as an EA modulator, and a dc responsivity of 0.45 A/W and output second-order intercept of $+34.5$ dBm when used as a detector. At 4 GHz, the broad-band and narrow-band spurious-free dynamic range of the transceiver as a modulator are, respectively, $106 \text{ dB-Hz}^{2/3}$ and $124 \text{ dB-Hz}^{4/5}$. The transceiver as a detector handles 20 mA of dc photocurrent, although it suffers an RF link gain penalty of 5.0 dB compared to a high-frequency InGaAs detector.

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